

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (High Speed U-MOS)

TPC8005-H

High Speed and High Efficiency DC-DC Converters

Lithium Ion Battery Applications

Portable Equipment Applications

Notebook PC Applications

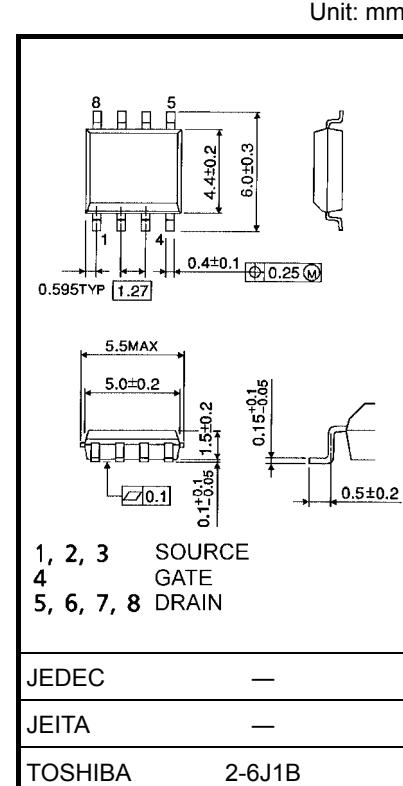
- Small footprint due to small and thin package
- High speed switching : 60% speed up (compare with current type)
- Small gate charge : $Q_g = 20 \text{ nC}$ (typ.)
- Low drain-source ON resistance : $R_{DS(\text{ON})} = 13 \text{ m}\Omega$ (typ.)
- High forward transfer admittance : $|Y_{fs}| = 16 \text{ S}$ (typ.)
- Low leakage current : $I_{DSS} = 10 \mu\text{A}$ (max) ($V_{DS} = 30 \text{ V}$)
- Enhancement-mode : $V_{th} = 1.3 \sim 2.5 \text{ V}$ ($V_{DS} = 10 \text{ V}$, $I_D = 1 \text{ mA}$)

Maximum Ratings ($T_a = 25^\circ\text{C}$)

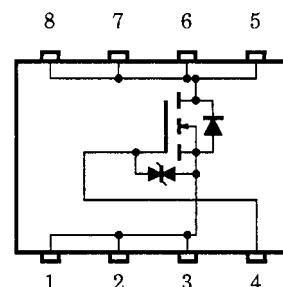
Characteristics		Symbol	Rating	Unit
Drain-source voltage		V_{DSS}	30	V
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V_{DGR}	30	V
Gate-source voltage		V_{GSS}	± 20	V
Drain current	DC (Note 1)	I_D	11	A
	Pulse (Note 1)	I_{DP}	44	
Drain power dissipation ($t = 10 \text{ s}$) (Note 2a)		P_D	2.4	W
Drain power dissipation ($t = 10 \text{ s}$) (Note 2b)		P_D	1.0	W
Single pulse avalanche energy (Note 3)		E_{AS}	157	mJ
Avalanche current		I_{AR}	11	A
Repetitive avalanche energy (Note 2a) (Note 4)		E_{AR}	0.24	mJ
Channel temperature		T_{ch}	150	$^\circ\text{C}$
Storage temperature range		T_{stg}	-55 to 150	$^\circ\text{C}$

Note: For (Note 1), (Note 2), (Note 3) and (Note 4), please refer to the next page.

This transistor is an electrostatic sensitive device. Please handle with caution.



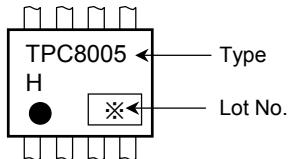
Weight: 0.080 g (typ.)

Circuit Configuration

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to ambient ($t = 10$ s)	R_{th} (ch-a)	52.1	°C/W
Thermal resistance, channel to ambient ($t = 10$ s)	R_{th} (ch-a)	125	°C/W

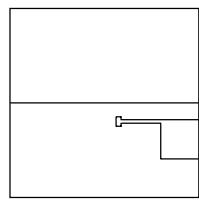
Marking (Note 5)



Note 1: Please use devices on condition that the channel temperature is below 150°C.

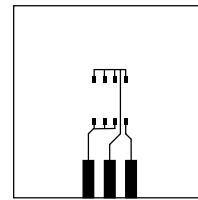
Note 2: (a) Device mounted on a glass-epoxy board (a)

(b) Device mounted on a glass-epoxy board (b)



FR-4
25.4 × 25.4 × 0.8
(unit: mm)

(a)



FR-4
25.4 × 25.4 × 0.8
(unit: mm)

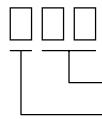
(b)

Note 3: $V_{DD} = 24$ V, $T_{ch} = 25^\circ\text{C}$ (initial), $L = 1.0$ mH, $R_G = 25$ Ω, $I_{AR} = 11$ A

Note 4: Reptitive rating; pulse width limited by maximum channel temperature

Note 5: ● on lower left of the marking indicates Pin 1.

* Weekly code: (Three digits)



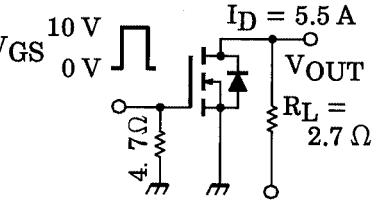
Week of manufacture

(01 for first week of year, continues up to 52 or 53)

Year of manufacture

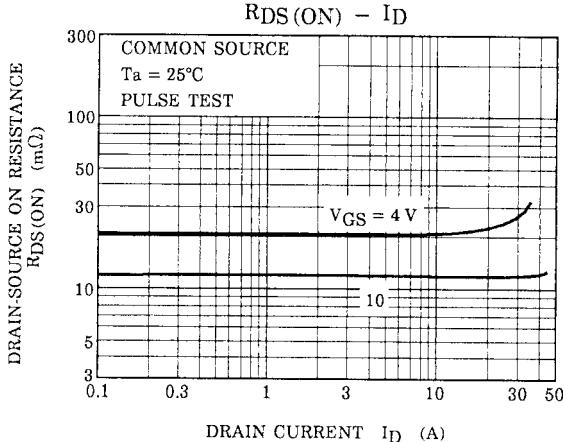
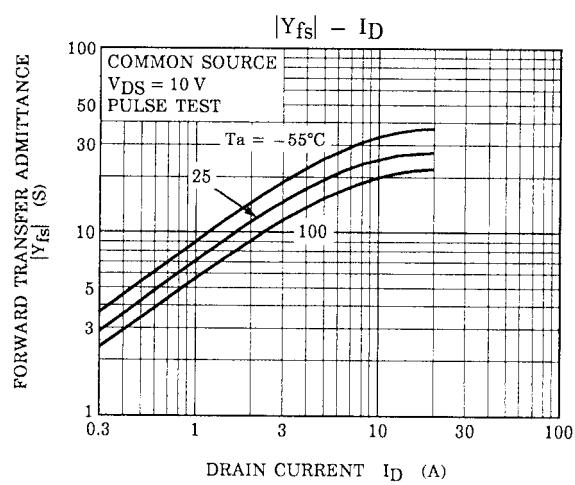
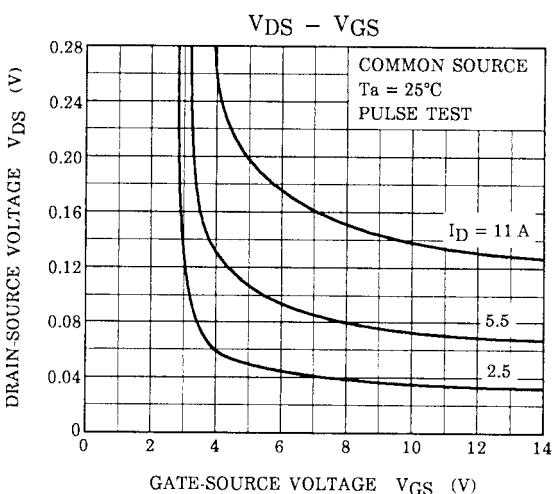
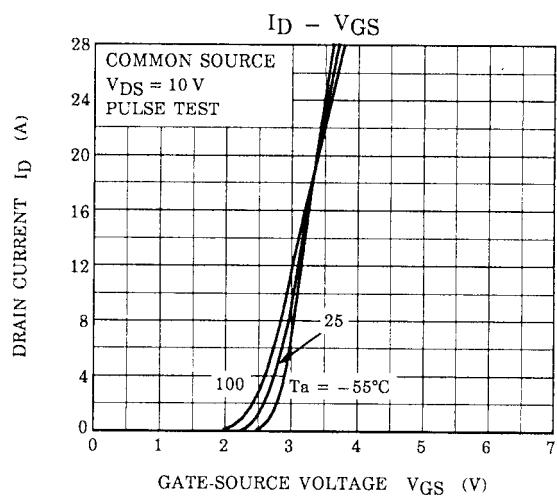
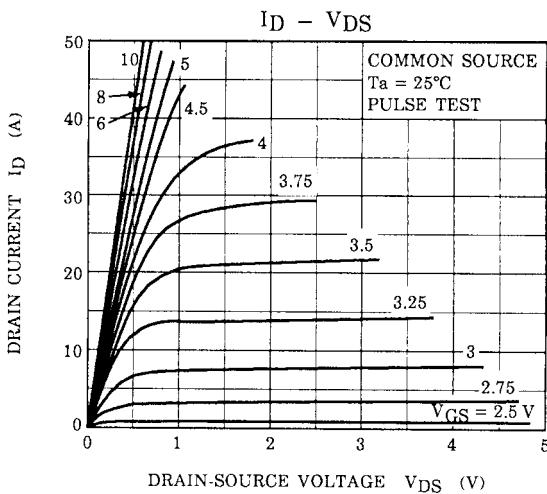
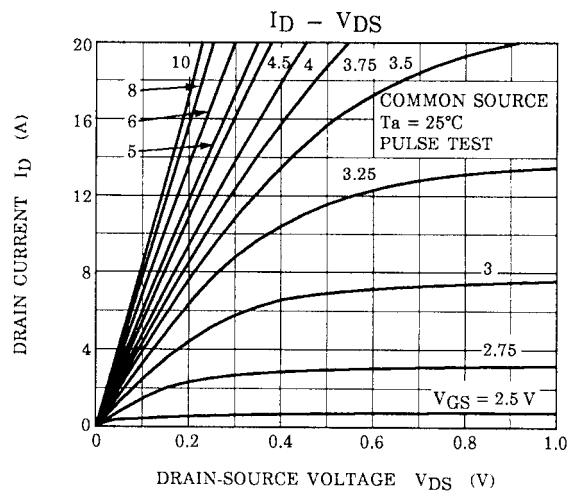
(One low-order digits of calendar year)

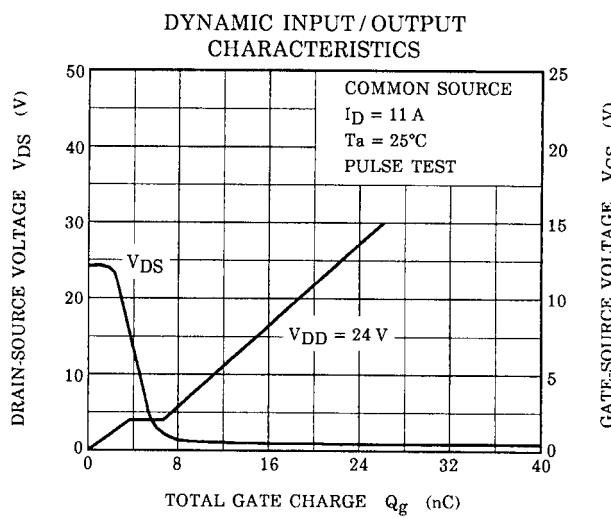
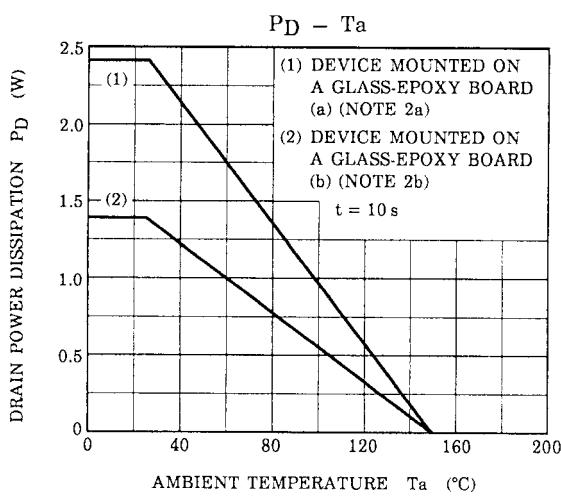
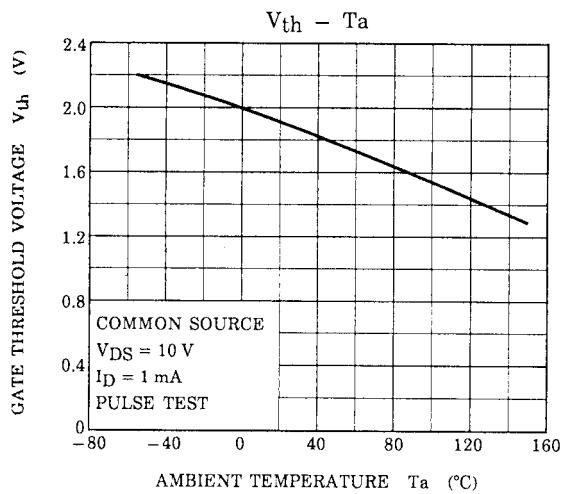
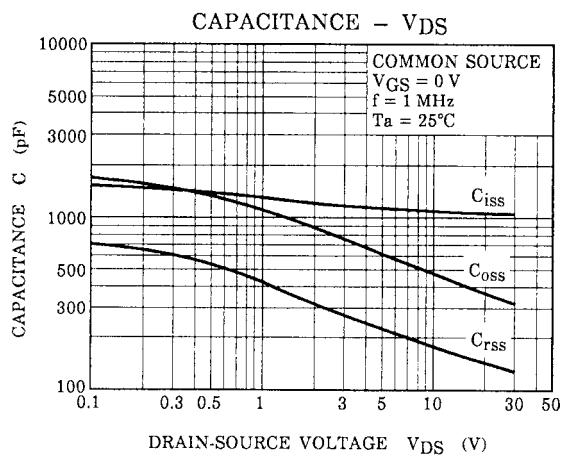
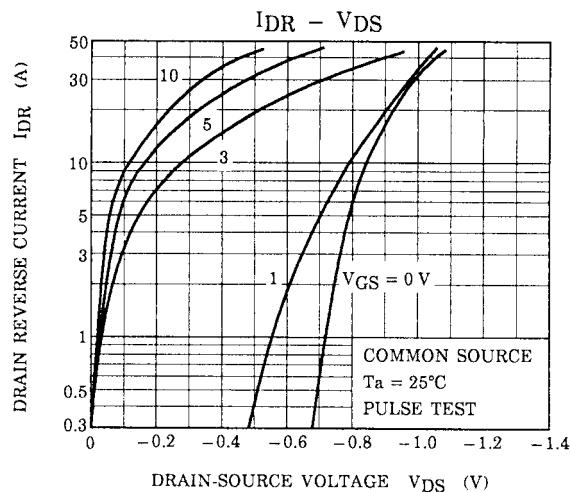
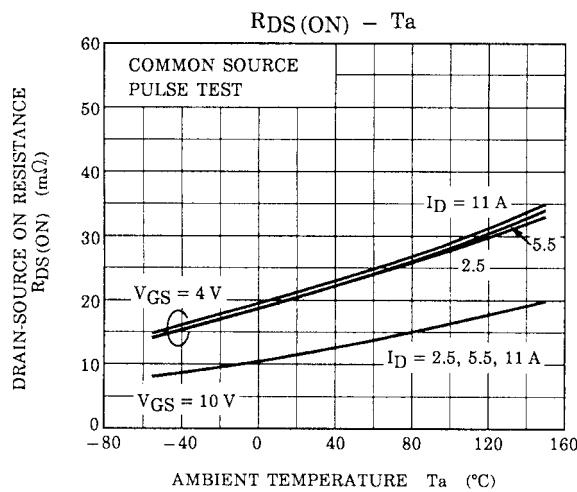
Electrical Characteristics (Ta = 25°C)

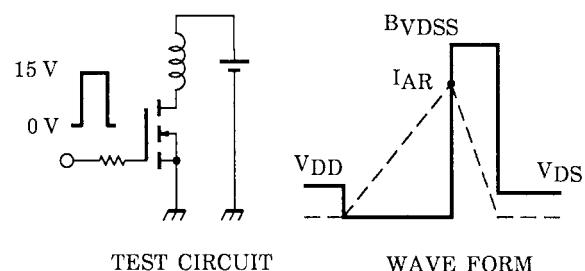
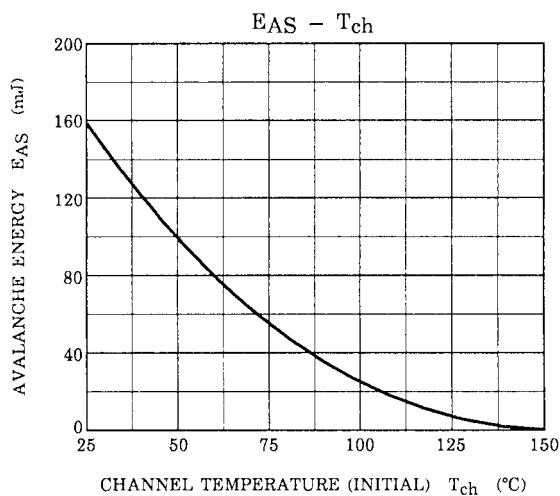
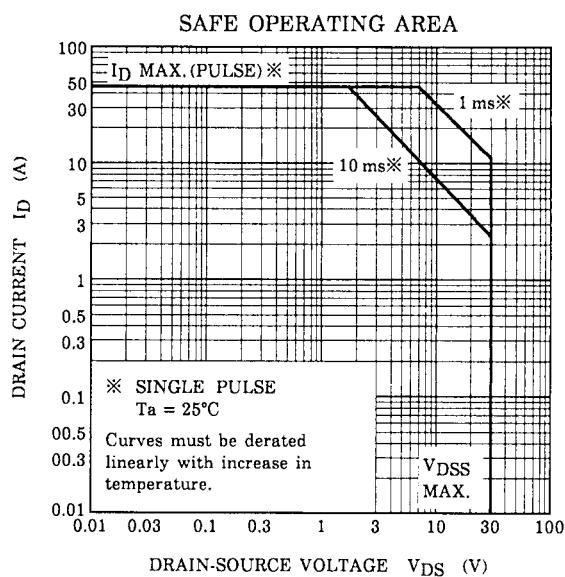
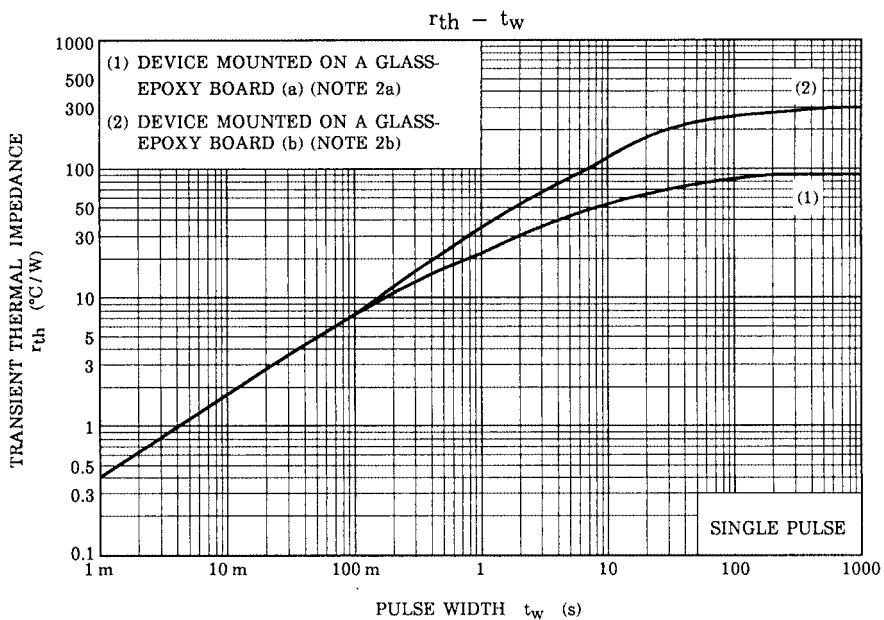
Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit	
Gate leakage current	I_{GSS}	$V_{GS} = \pm 16 \text{ V}$, $V_{DS} = 0 \text{ V}$	—	—	± 10	μA	
Drain cut-off current	I_{DSS}	$V_{DS} = 30 \text{ V}$, $V_{GS} = 0 \text{ V}$	—	—	10	μA	
Drain-source breakdown voltage	$V_{(BR) DSS}$	$I_D = 10 \text{ mA}$, $V_{GS} = 0 \text{ V}$	30	—	—	V	
	$V_{(BR) DSX}$	$I_D = 10 \text{ mA}$, $V_{GS} = -20 \text{ V}$	15	—	—	V	
Gate threshold voltage	V_{th}	$V_{DS} = 10 \text{ V}$, $I_D = 1 \text{ mA}$	1.3	—	2.5	V	
Drain-source ON resistance	$R_{DS (\text{ON})}$	$V_{GS} = 4.5 \text{ V}$, $I_D = 5.5 \text{ A}$	—	23	27	$\text{m}\Omega$	
	$R_{DS (\text{ON})}$	$V_{GS} = 10 \text{ V}$, $I_D = 5.5 \text{ A}$	—	13	16	$\text{m}\Omega$	
Forward transfer admittance	$ Y_{fs} $	$V_{DS} = 10 \text{ V}$, $I_D = 5.5 \text{ A}$	8	16	—	S	
Input capacitance	C_{iss}	$V_{DS} = 10 \text{ V}$, $V_{GS} = 0 \text{ V}$, $f = 1 \text{ MHz}$	—	1150	—	pF	
Reverse transfer capacitance	C_{rss}		—	140	—		
Output capacitance	C_{oss}		—	400	—		
Switching time	Rise time	t_r	 V_{GS} 10 V 0 V $I_D = 5.5 \text{ A}$ V_{OUT} $R_L = 2.7 \Omega$ 4Ω 4.7Ω $V_{DD} \approx 15 \text{ V}$ $Duty \leq 1\%$, $t_W = 10 \mu\text{s}$	—	4	—	ns
	Turn-on time	t_{on}		—	12	—	
	Fall time	t_f		—	8	—	
	Turn-off time	t_{off}		—	40	—	
Total gate charge (Gate-source plus gate-drain)	Q_g	$V_{DD} \approx 24 \text{ V}$, $V_{GS} = 10 \text{ V}$, $I_D = 11 \text{ A}$	—	20	—	nC	
Gate-source charge	Q_{gs}		—	15	—		
Gate-drain ("miller") charge	Q_{gd}		—	5	—		

Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Drain reverse current	Pulse (Note 1)	I_{DRP}	—	—	—	44	A
Forward voltage (diode)		V_{DSF}	$I_{DR} = 11 \text{ A}$, $V_{GS} = 0 \text{ V}$	—	—	-1.2	V







$$T_{ch} = 25^\circ\text{C} \text{ (Initial)} \quad E_{AS} = \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{BVDSS}{BVDSS - V_{DD}} \right)$$

Peak $I_{AR} = 11 \text{ A}$, $R_G = 25 \Omega$
 $V_{DD} = 24 \text{ V}$, $L = 1.0 \text{ mH}$

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